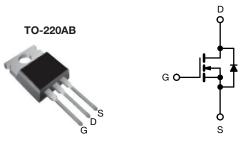


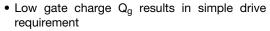
Power MOSFET



N_Channal	MOSEET

PRODUCT SUMMARY					
V _{DS} (V)	400				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.55			
Q _g (Max.) (nC)	36				
Q _{gs} (nC)	9.9				
Q _{gd} (nC)	16				
Configuration	Single				

FEATURES





- Improved gate, avalanche, and dynamic dV/dt ruggedness
- Fully characterized capacitance and avalanche voltage and current
- Effective C_{oss} specified
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

APPLICATIONS

- Switch mode power supply (SMPS)
- Uninterruptable power supply
- · High speed power switching

TYPICAL SMPS TOPOLOGIES

- · Single transistor flyback Xfmr. reset
- Single transistor forward Xfmr. reset (both for US line input only)

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free	IRF740APbF			
Lead (Pb)-free and halogen-free	IRF740APbF-BE3			

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V _{DS}	400		
Gate-source voltage			V_{GS}	± 30	V	
Continuous drain current	V _{GS} at 10 V	T _C = 25 °C	1-	10	А	
		T _C = 100 °C	I _D	6.3		
Pulsed drain current a			I _{DM}	40		
Linear derating factor				1.0	W/°C	
Single pulse avalanche energy b			E _{AS}	630	mJ	
Repetitive avalanche current a			I _{AR}	10	Α	
Repetitive avalanche energy ^a			E _{AR}	12.5	mJ	
Maximum power dissipation	T _C = 25 °C		P_{D}	125	W	
Peak diode recovery dV/dt ^c			dV/dt	5.9	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering recommendations (peak temperature) ^d	For	10 s		300 ^d		
Mounting torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N·m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 12.6 mH, R_q = 25 Ω , I_{AS} = 10 A (see fig. 12)
- c. $I_{SD} \le 10$ A, $dV/dt \le 330$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	62		
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static		<u> </u>					
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		400	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference t	Reference to 25 °C, I _D = 1 mA		0.48	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		-	4.0	V
Gate-source leakage	I _{GSS}	V _G	V _{GS} = ± 30 V		-	± 100	nA
Zana anto valta an dunia accumunt	1	V _{DS} = 400 V, V _{GS} = 0 V		-	-	25	
Zero gate voltage drain current	I _{DSS}	S V _{DS} = 320 V, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA	
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 6.0 A ^b	-	-	0.55	Ω
Forward transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 6.0 A ^b		4.9	-	-	S
Dynamic							
Input capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$		-	1030	-	pF
Output capacitance	C _{oss}			-	170	-	
Reverse transfer capacitance	C _{rss}			-	7.7	-	
Output canceitance	C	V _{GS} = 0 V, V _{DS} = 1.0 V, f = 1.0 MHz	-	1490	-		
Output capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 320 V, f = 1.0 MHz		-	52	-	
Effective output capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 0 V to 320 V		-	61	-	
Total gate charge	Q_g			-	-	36	
Gate-source charge	Q_{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 10 \text{ A}, V_{DS} = 320 \text{ V},$ see fig. 6 and 13 ^b	-	-	9.9	nC	
Gate-drain charge	Q_{gd}		see lig. o and 15	-	-	16	
Turn-on delay time	t _{d(on)}	,		-	10	-	ns
Rise time	t _r	V _{DD} = 2	$V_{DD} = 200 \text{ V}, I_D = 10 \text{ A},$		35	-	
Turn-off delay time	t _{d(off)}	$R_{g} = 10 \Omega$, $R_{D} = 19.5 \Omega$, see fig. 10^{b}		-	24	-	
Fall time	t _f			-	22	-	
Drain-Source Body Diode Characteristic	s	•					
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	10	A
Pulsed diode forward current ^a	I _{SM}			-	-	40	
Body diode voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 10 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.0	V
Body diode reverse recovery time	t _{rr}	T _J = 25 °C, I _F = 10 A, dl/dt = 100 A/μs ^b		-	240	360	ns
Body diode reverse recovery charge	Q _{rr}			-	1.9	2.9	μC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-o			minated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;~duty~cycle \leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

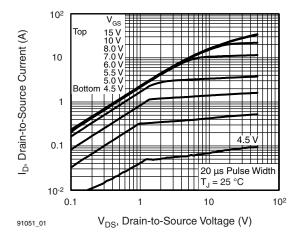


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

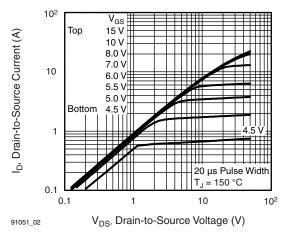


Fig. 1 - Typical Output Characteristics, T_C = 150 °C

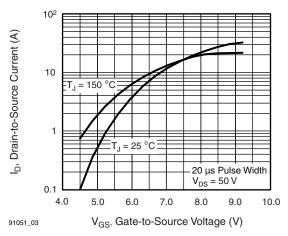


Fig. 2 - Typical Transfer Characteristics

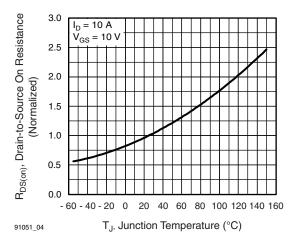


Fig. 3 - Normalized On-Resistance vs. Temperature

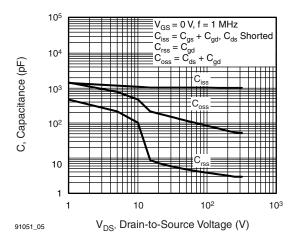


Fig. 4 - Typical Capacitance vs. Drain-to-Source Voltage

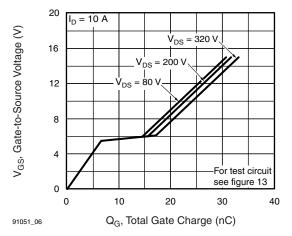


Fig. 5 - Typical Gate Charge vs. Gate-to-Source Voltage



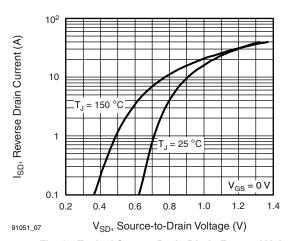


Fig. 6 - Typical Source-Drain Diode Forward Voltage

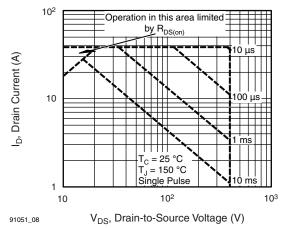


Fig. 7 - Maximum Safe Operating Area

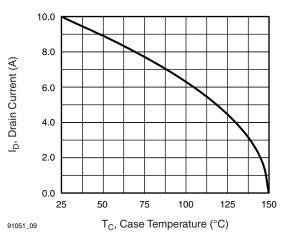


Fig. 8 - Maximum Drain Current vs. Case Temperature

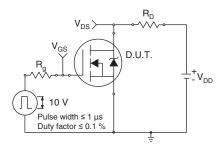


Fig. 9 - Switching Time Test Circuit

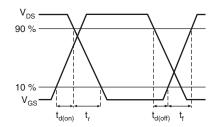


Fig. 10 - Switching Time Waveforms

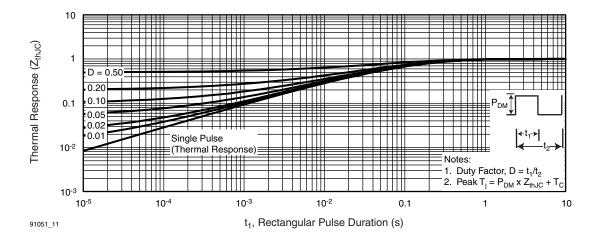




Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

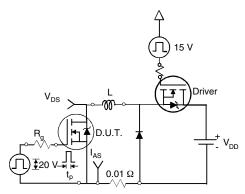


Fig. 12 - Unclamped Inductive Test Circuit

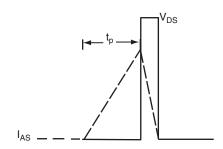


Fig. 13 - Unclamped Inductive Waveforms

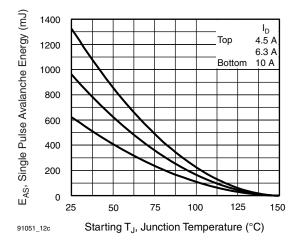


Fig. 14 - Maximum Avalanche Energy vs. Drain Current

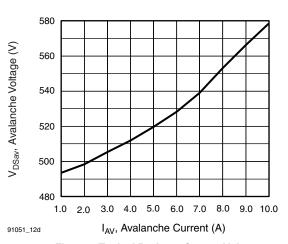


Fig. 15 - Typical Drain-to-Source Voltage vs.
Avalanche Current

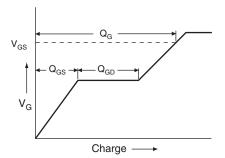


Fig. 16 - Basic Gate Charge Waveform

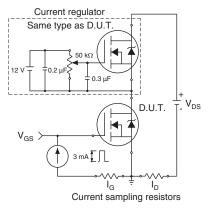
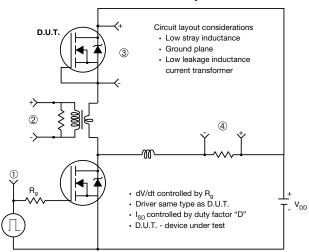


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



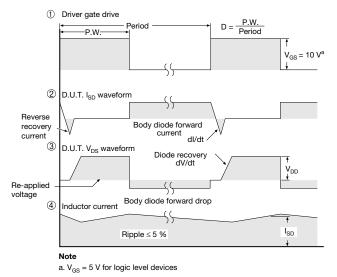


Fig. 18 - For N-Channel

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